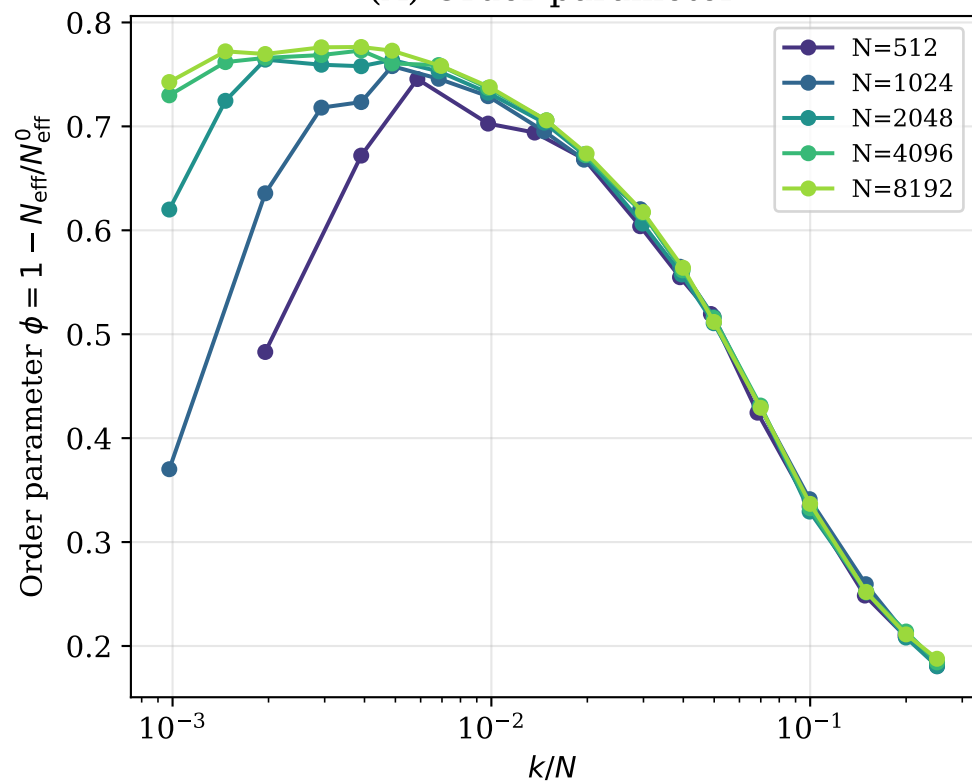
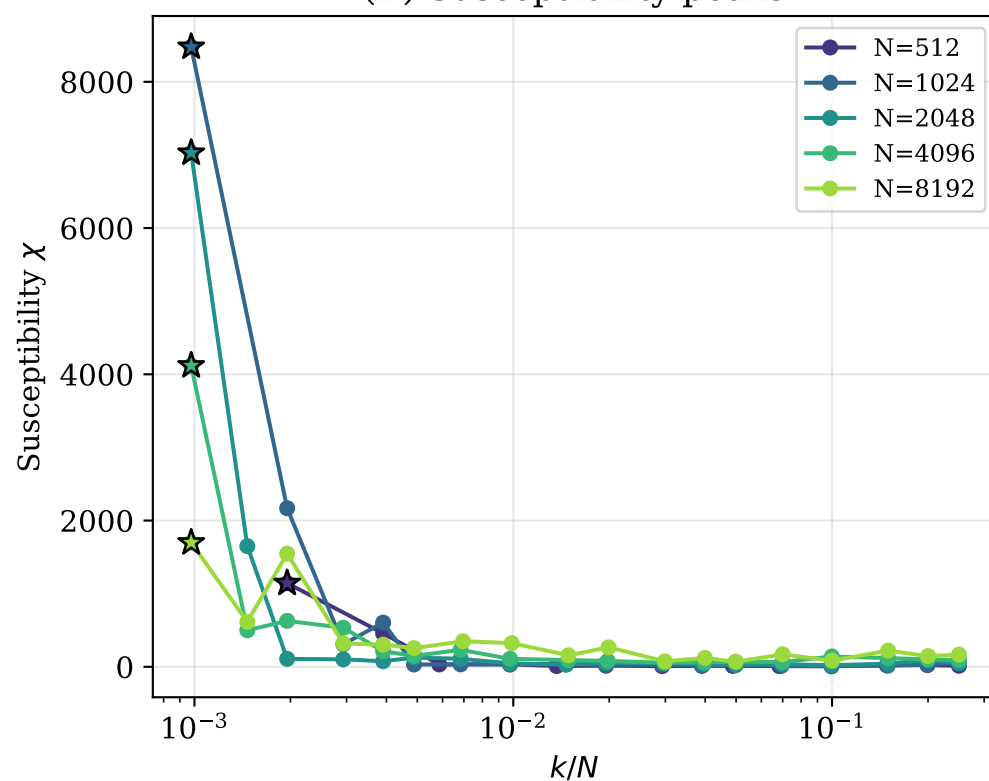


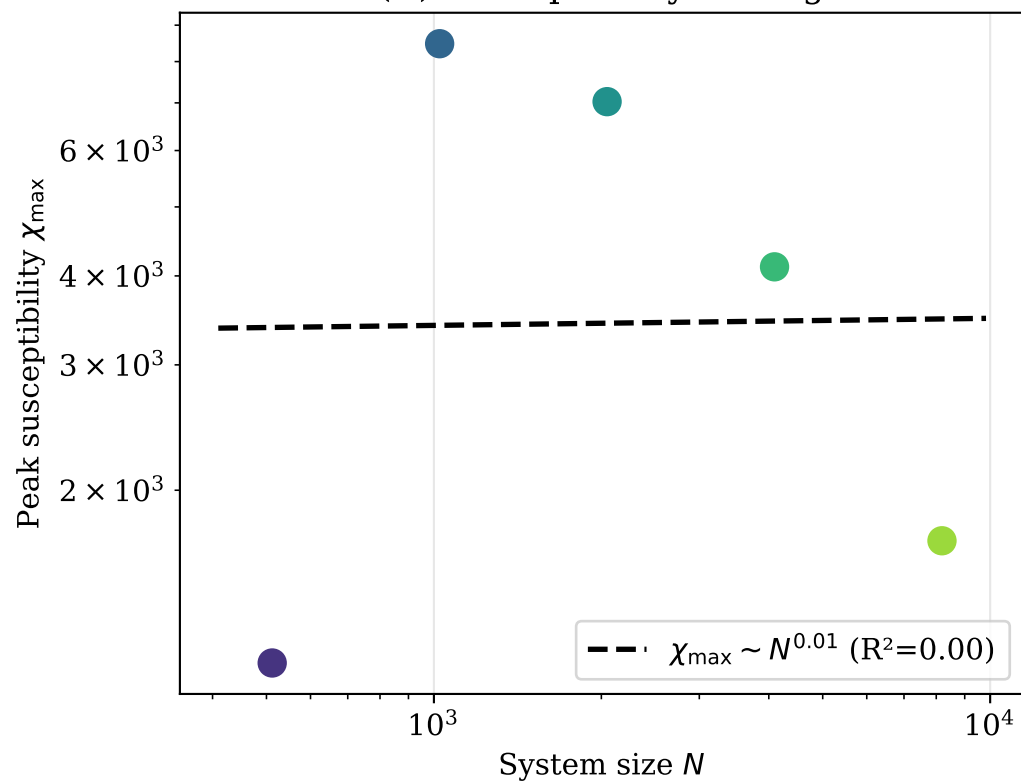
(A) Order parameter



(B) Susceptibility peaks



(C) Susceptibility scaling



(D) Critical point drift

